Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/074,996	LEE ET AL.
Examiner	Art Unit
Christopher A. Revak	2131

SEARCHED					
Class	Subclass	Date	Examiner		
none	none	12/20/2006	CR		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
BRS Text Search USPAT (see attached strategy)	12/20/2006	CR
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